

Notice of References Cited	Application/Control No. 10/711,446	Applicant(s)/Patent Under Reexamination LIU, YU-CHENG	
	Examiner M. Wilczewski	Art Unit 2822	Page 1 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,015,594	01-2000	Yoshikawa, Toshiaki	427/398.1
*	B	US-2003/0116427	06-2003	Ding et al.	204/192.17
*	C	US-3,856,918	12-1974	Skrivan et al.	423/69
*	D	US-4,339,326	07-1982	Hirose et al.	204/298.38
*	E	US-6,270,633	08-2001	Onaka et al.	204/192.12
*	F	US-6,284,110	09-2001	Sill, Edward L.	204/298.09
*	G	US-6,641,701	11-2003	Tepman, Avi	204/192.1
*	H	US-6,689,254	02-2004	Hurwitt, Steven	204/192.12
*	I	US-2001/0042594	11-2001	SHAMOUILIAN et al.	156/345
*	J	US-2003/0164288	09-2003	Onishi, Shinzo	204/192.12
*	K	US-6,063,233	05-2000	Collins et al.	156/345.37
*	L	US-4,771,730	09-1988	Tezuka, Masashi	118/723E
*	M	US-5,478,609	12-1995	Okamura, Nobuyuki	427/572

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/711,446		Applicant(s)/Patent Under Reexamination LIU, YU-CHENG	
	Examiner M. Wilczewski		Art Unit 2822	Page 2 of 2

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,478,609	12-1995	Okamura, Nobuyuki	427/572
*	B	US-5,744,016	04-1998	Yamada et al.	204/298.11
*	C	US-5,892,207	04-1999	Kawamura et al.	219/492
*	D	US-3,856,918	12-1974	Skrivan et al.	423/69
*	E	US-5,328,585	07-1994	Stevenson et al.	204/298.2
*	F	US-6,673,716	01-2004	D'Couto et al.	438/656
*	G	US-2002/0175070	11-2002	Furuta, Masahiro	204/192.16
*	H	US-5,858,183	01-1999	Wolters et al.	204/192.17
*	I	US-2001/0014540	08-2001	Shan et al.	438/710
*	J	US-5,930,593	07-1999	Tsai et al.	438/50
*	K	US-6,811,662	11-2004	Liu, Yu-Cheng	204/298.09
*	L	US-2002/0022089	02-2002	Kim et al.	427/255.36
*	M	US-6,635,570	10-2003	Galewski et al.	438/681

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.